



**12500 TI Boulevard, MS 8640, Dallas, Texas 75243**

**PCN#20241105001.2**  
**Qualification of TI Clark as an additional Assembly & Test/Probe site**  
**for select devices**  
**Change Notification / Sample Request**

**Date:** November 05, 2024  
**To:** MOUSER PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

Texas Instruments requires acknowledgement of receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance and approval of this change. If samples or additional data are required, requests must be received within **30 days** of this notification.

The changes discussed within this PCN will not take effect any earlier than the proposed first ship date on Page 3 of this notification, unless customer agreement has been reached on an earlier implementation of the change.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice or to provide acknowledgement of this PCN, you may contact your local Field Sales Representative or the change management team.

For sample requests or sample related questions, contact your local Field Sales Representative.

Sincerely,

Change Management Team  
SC Business Services







**20241105001.2**  
**Attachment: 1**

**Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, you have recently purchased these devices. The corresponding customer part number is also listed, if available.

<b>DEVICE</b>	<b>CUSTOMER PART NUMBER</b>
TPS552882QWRPMRQ1	595-PS552882QWRPMRQ1
TPS55288QWRPMRQ1	NULL

Technical details of this Product Change follow on the next page(s).

<b>PCN Number:</b>	PCN#20241105001.2	<b>PCN Date:</b>	November 05, 2024									
<b>Title:</b>	Qualification of TI Clark as an additional Assembly & Test/Probe site for select devices											
<b>Customer Contact:</b>	Change Management Team	<b>Dept:</b>	Quality Services									
<b>Proposed 1<sup>st</sup> Ship Date:</b>	May 04, 2025	<b>Sample requests accepted until:</b>	December 05, 2024*									
<b>*Sample requests received after December 05, 2024 will not be supported.</b>												
<b>Change Type:</b>												
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Design									
<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Data Sheet									
<input type="checkbox"/>	Assembly Materials	<input type="checkbox"/>	Part number change									
<input type="checkbox"/>	Mechanical Specification	<input checked="" type="checkbox"/>	Test Site									
<input checked="" type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process									
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Material									
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Process									
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Site									
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Material									
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Process									
<b>PCN Details</b>												
<b>Description of Change:</b>												
Texas Instruments Incorporated is announcing the qualification of TI Clark as an additional Assembly & Test/Probe site for the devices in the product affected section. No material differences between sites.												
<table><tr><td></td><td><b>CDAT</b></td><td><b>TI Clark</b></td></tr><tr><td>Probe site</td><td>CD-PR</td><td><b>Clark PR</b></td></tr><tr><td>Final Test Site</td><td>CDAT</td><td><b>Clark</b></td></tr></table>					<b>CDAT</b>	<b>TI Clark</b>	Probe site	CD-PR	<b>Clark PR</b>	Final Test Site	CDAT	<b>Clark</b>
	<b>CDAT</b>	<b>TI Clark</b>										
Probe site	CD-PR	<b>Clark PR</b>										
Final Test Site	CDAT	<b>Clark</b>										
Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ												
<b>Reason for Change:</b>												
Supply continuity												
<b>Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):</b>												
None												
<b>Impact on Environmental Ratings</b>												
Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.												
<table><tr><td><b>RoHS</b></td><td><b>REACH</b></td><td><b>Green Status</b></td><td><b>IEC 62474</b></td></tr><tr><td><input checked="" type="checkbox"/> No Change</td><td><input checked="" type="checkbox"/> No Change</td><td><input checked="" type="checkbox"/> No Change</td><td><input checked="" type="checkbox"/> No Change</td></tr></table>				<b>RoHS</b>	<b>REACH</b>	<b>Green Status</b>	<b>IEC 62474</b>	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	
<b>RoHS</b>	<b>REACH</b>	<b>Green Status</b>	<b>IEC 62474</b>									
<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change	<input checked="" type="checkbox"/> No Change									
<b>Changes to product identification resulting from this PCN:</b>												
<b>Assembly Site</b>	<b>Assembly Site Origin (22L)</b>	<b>Assembly Country Code (23L)</b>	<b>Assembly City</b>									
TI Chengdu	CDA	CHN	Chengdu									
<b>TI Clark</b>	<b>QAB</b>	<b>PHL</b>	<b>Angeles City, Pampanga</b>									
Sample product shipping label (not actual product label)												
<table><tr><td> MADE IN: Malaysia 2DC: 20: MSL 2 /260C/1 YEAR MSL 1 /235C/UNLIM OPT: 39 ITEM: 5A (L)T0:1750</td><td></td><td>(1P) SN74LS07NSR (Q) 2000 (D) 0336 (31T) LOT: 3959047MLA (4W) TKY (1T) 7523483SI2 (P) (2P) REV: (V) 0033317 (20L) CS0: SHE (21L) CC0: USA (22L) AS0: MLA (23L) ACO: MYS</td></tr></table>				 MADE IN: Malaysia 2DC: 20: MSL 2 /260C/1 YEAR MSL 1 /235C/UNLIM OPT: 39 ITEM: 5A (L)T0:1750		(1P) SN74LS07NSR (Q) 2000 (D) 0336 (31T) LOT: 3959047MLA (4W) TKY (1T) 7523483SI2 (P) (2P) REV: (V) 0033317 (20L) CS0: SHE (21L) CC0: USA (22L) AS0: MLA (23L) ACO: MYS						
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**Product Affected:**

TPS552882QWRPMPRQ1    TPS55288QWRPMPRQ1

**Qualification Report****Automotive Qualification Summary  
(As per AEC-Q100 Rev. J and JEDEC Guidelines)**

Approve Date 17-October -2024

**Product Attributes**

Attributes	Qual Device:	Qual Device:	QBS Process Reference:	QBS Product Reference:	QBS Package Reference:
	TPS552882QWRPMPRQ1	TPS55288QWRPMPRQ1	TPS61378QWRTERQ1	TPS552882QRPMPRQ1	TPS552882QRPMPRQ1
Automotive Grade Level	Grade 1	Grade 1	Grade 1	Grade 1	Grade 1
Operating Temp Range (C)	-40 to 125	-40 to 125	-40 to 125	-40 to 125	-40 to 125
Product Function	Power Management	Power Management	Power Management	Power Management	Power Management
Wafer Fab Supplier	RFAB	RFAB	RFAB	RFAB	RFAB
Assembly Site	CLARK-AT	CLARK-AT	CDAT	CDAT	CLARK-AT
Package Group	QFN	QFN	QFN	QFN	QFN
Package Designator	RPM	RPM	RTE	RPM	RPM
Pin Count	26	26	16	26	26

QBS: Qual By Similarity, also known as Generic Data

Qual Device TPS552882QWRPMPRQ1 is qualified at MSL2 260C

Qual Device TPS55288QWRPMPRQ1 is qualified at MSL2 260C

**Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Type	#	Test Spec	Min Lot Qty	SS / Lot	Test Name	Condition	Duration	Qual Device:	Qual Device:	QBS Process Reference:	QBS Product Reference:	QBS Package Reference:
								TPS552882QWRPMPRQ1	TPS55288QWRPMPRQ1	TPS61378QWRTERQ1	TPS552882QRPMPRQ1	TPS552882QRPMPRQ1
PC	A1	JEDEC J-STD-020 JESD22-A113	3	77	Preconditioning	MSL2 260C	-	-	-	3/0/0	3/0/0	3/0/0
HAST	A2	JEDEC JESD22-A110	3	77	Biased HAST	130C/85%RH	96 Hours	-	-	3/231/0	3/231/0	3/231/0
ACU/HAST	A3	JEDEC JESD22-A102/JEDEC JESD22-A118	3	77	Unbiased HAST	130C/85%RH	96 Hours	-	-	3/231/0	3/231/0	3/231/0
TC	A4	JEDEC JESD22-A104 and Appendix 3	3	77	Temperature Cycle	-55C/150C	1000 Cycles	-	-	-	-	3/231/0
TC	A4	JEDEC JESD22-A104 and Appendix 3	3	77	Temperature Cycle	-65C/150C	500 Cycles	-	-	3/231/0	3/231/0	-
PTC	A5	JEDEC JESD22-A105	1	45	PTC	-40/125C	1000 Cycles	-	-	1/45/0	1/45/0	-
HTSL	A6	JEDEC JESD22-A103	1	45	High Temperature Storage Life	150C	1000 Hours	-	-	-	-	1/45/0
HTSL	A6	JEDEC JESD22-A103	1	45	High Temperature Storage Life	175C	500 Hours	-	-	3/135/0	-	-
Test Group B - Accelerated Lifetime Simulation Tests												
HTOL	B1	JEDEC JESD22-A108	3	77	Life Test	150C	408 Hours	-	-	3/231/0	3/231/0	-
ELFR	B2	AEC Q100-008	3	800	Early Life Failure Rate	125C	48 Hours	-	-	3/2400/0	1/800/0	-

Test Group C - Package Assembly Integrity Tests												
WBS	C1	AEC Q100-001	1	30	Wire Bond Shear	Minimum of 5 devices, 30 wires Cpk>1.67	Wires	1/30/0	-		3/90/0	-
WBP	C2	MIL-STD883 Method 2011	1	30	Wire Bond Pull	Minimum of 5 devices, 30 wires Cpk>1.67	Wires	1/30/0	-		3/90/0	-
SD	C3	JEDEC J-STD-002	1	15	PB Solderability	>95% Lead Coverage	-	-	-		1/15/0	1/15/0
SD	C3	JEDEC J-STD-002	1	15	PB-Free Solderability	>95% Lead Coverage	-	1/15/0	-		1/15/0	1/15/0
PD	C4	JEDEC JESD22-B100 and B108	3	10	Physical Dimensions	Cpk>1.67	-	1/10/0	-		3/30/0	3/30/0
Test Group D - Die Fabrication Reliability Tests												
EM	D1	JESD61	-	-	Electromigration	-	-	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements
TDD8	D2	JESD35	-	-	Time Dependent Dielectric Breakdown	-	-	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements
HCI	D3	JESD60 & 28	-	-	Hot Carrier Injection	-	-	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements
BTI	D4	-	-	-	Bias Temperature Instability	-	-	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements
SM	D5	-	-	-	Stress Migration	-	-	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements	Completed Per Process Technology Requirements
Test Group E - Electrical Verification Tests												
ESD	E2	AEC Q100-002	1	3	ESD HBM	-	3000 Volts	-	-		1/3/0	1/3/0
ESD	E3	AEC Q100-011	1	3	ESD CDM	-	500 Volts	-	-		1/3/0	1/3/0
LU	E4	AEC Q100-004	1	3	Latch-Up	Per AEC Q100-004	-	-	-		1/6/0	1/6/0
ED	E5	AEC Q100-009	3	30	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	1/30/0	1/30/0		3/90/0	3/90/0
Additional Tests												
BLR	T1	-	-	-	Board Level Reliability - Temp Cycle	-40/125C	1000 Cycles	-	-		1/32/0	-

Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

#### Ambient Operating Temperature by Automotive Grade Level:

Grade 0 (or E): -40C to +150C

Grade 1 (or Q): -40C to +125C

Grade 2 (or T): -40C to +105C

Grade 3 (or I) : -40C to +85C

#### E1 (TEST): Electrical test temperatures of Qual samples (High temperature according to Grade level):

Room/Hot/Cold : HTOL, ED

Room/Hot : THB / HAST, TC / PTC, HTSL, ELFR, ESD & LU

Room : AC/uHAST

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

ZVEI IDs: SEM-PA-18, SEM-TF-01

For questions regarding this notice, e-mails can be sent to the Change Management team or your local Field Sales Representative.

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